Silicon N-Channel MOS FET

HITACHI

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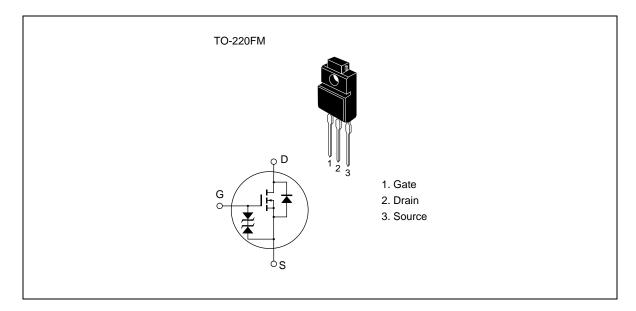
Application

High speed power switching

Features

- Low on-resistance
- High speed switching
- Low drive current
- No secondary breakdown
- Suitable for switching regulator and DC-DC converter

Outline



Absolute Maximum Ratings ($Ta = 25^{\circ}C$)

Item	Symbol	Ratings	Unit	
Drain to source voltage	V _{dss}	600	V	
Gate to source voltage	V _{gss}	±30	V	
Drain current	I _D	5	А	
Drain peak current	+1 D(pulse)	20	А	
Body to drain diode reverse drain current	I _{DR}	5	А	
Channel dissipation	Pch*2	35	W	
Channel temperature	Tch	150	°C	
Storage temperature	Tstg	-55 to +150	°C	

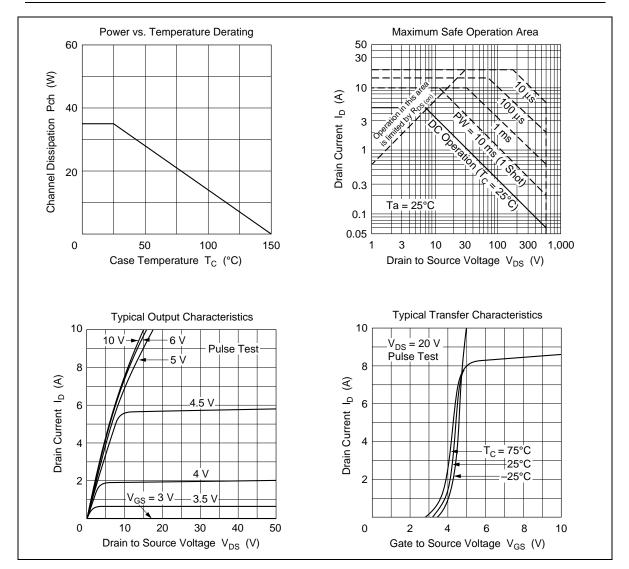
Notes 1. PW \leq 10 μ s, duty cycle \leq 1%

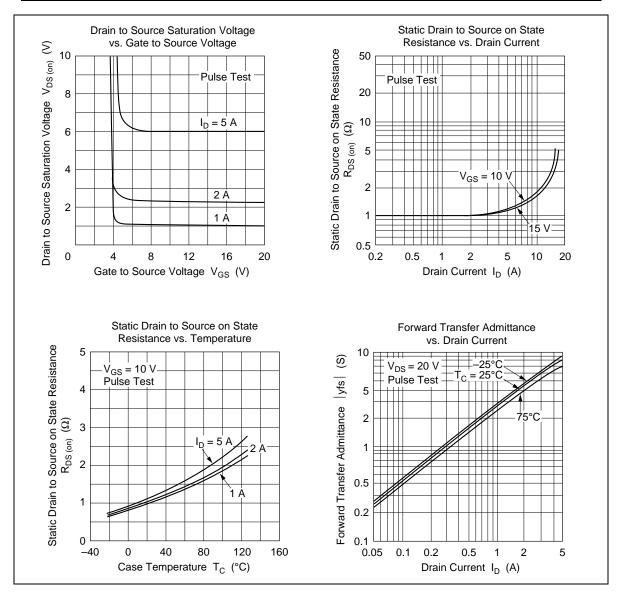
2. Value at $T_c = 25^{\circ}C$

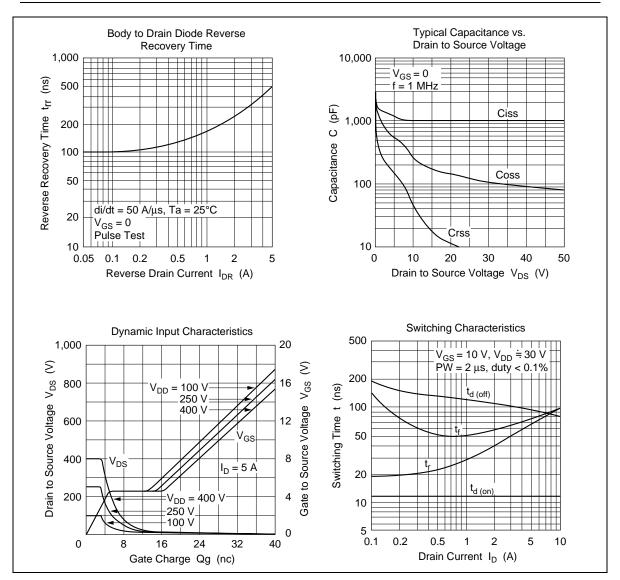
Electrical Characteristics ($Ta = 25^{\circ}C$)

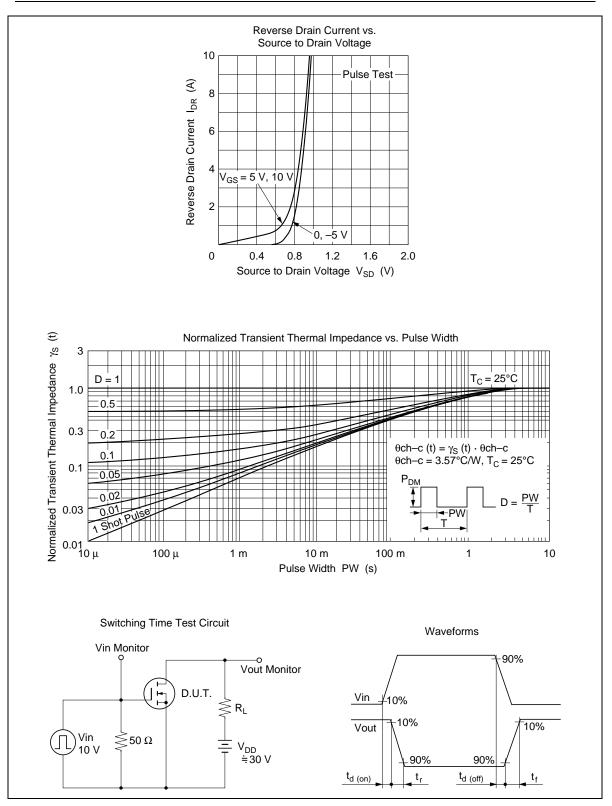
Item	Symbol	Min	Тур	Max	Unit	Test conditions
Drain to source breakdown voltage	$V_{\scriptscriptstyle (BR)DSS}$	600		_	V	$I_{D} = 10 \text{ mA}, V_{GS} = 0$
Gate to source breakdown voltage	$V_{\scriptscriptstyle (BR)GSS}$	±30	_	_	V	$I_{g} = \pm 100 \ \mu A, \ V_{DS} = 0$
Gate to source leak current	I _{GSS}	—	_	±10	μA	$V_{\text{gs}} = \pm 25$ V, $V_{\text{ds}} = 0$
Zero gate voltage drain current	I _{DSS}	_	_	250	μA	$V_{\rm DS} = 500 \text{ V}, V_{\rm GS} = 0$
Gate to source cutoff voltage	$V_{\text{GS(off)}}$	2.0	—	3.0	V	$I_{D} = 1 \text{ mA}, V_{DS} = 10 \text{ V}$
Static drain to source on state resistance	$R_{\scriptscriptstyle DS(\text{on})}$	_	1.1	1.5	Ω	$I_{D} = 2.5 \text{ A}, \text{ V}_{GS} = 10 \text{ V}^{*1}$
Forward transfer admittance	yfs	3.0	5.0	_	S	$I_{D} = 2.5 \text{ A}, \text{ V}_{DS} = 10 \text{ V}^{*1}$
Input capacitance	Ciss	_	1000	_	pF	$V_{_{DS}} = 10 \text{ V}, V_{_{GS}} = 0,$
Output capacitance	Coss		250		pF	f = 1 MHz
Reverse transfer capacitance	Crss	—	45	—	pF	
Turn-on delay time	t _{d(on)}		12		ns	$I_{_{\rm D}}$ = 2.5 A, $V_{_{\rm GS}}$ = 10 V,
Rise time	t,	—	45	—	ns	R _L = 12 Ω
Turn-off delay time	$\mathbf{t}_{d(off)}$	—	105		ns	
Fall time	t _f	—	55	—	ns	
Body to drain diode forward voltage	V_{DF}	_	0.9	_	V	$I_{F} = 5 \text{ A}, V_{GS} = 0$
Body to drain diode reverse recovery time	t _{rr}	—	500	—	ns	$I_{F} = 5 \text{ A}, V_{GS} = 0,$ $di_{F}/dt = 100 \text{ A}/\mu\text{s}$
Note 1. Pulse test						

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